POWERTRENCH® Power Clip 30 V Asymmetric Dual N-Channel MOSFETs

General Description

This device includes two specialized N-Channel MOSFETs in a dual package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFET $^{\text{TM}}$ (Q2) have been designed to provide optimal power efficiency.

Features

Q1: N-Channel

- Max $R_{DS(on)} = 3.25 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 19 \text{ A}$
- Max $R_{DS(on)} = 4 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 17 \text{ A}$

Q2: N-Channel

- Max $R_{DS(on)} = 0.97 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 37 \text{ A}$
- Max $R_{DS(on)} = 1.25 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 34 \text{ A}$
- Low Inductance Packaging Shortens Rise/Fall Times, Resulting in Lower Switching Losses.
- MOSFET Integration Enables Optimum Layout for Lower Circuit Inductance and Reduced Switch Node Ringing.
- RoHS Compliant

Applications

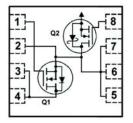
- Computing
- Communications
- General Purpose Point of Load



ON Semiconductor®

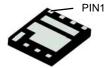
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ELECTRICAL CONNECTION



N-Channel MOSFET





Top View

Bottom View

Power Clip 56 (PQFN8 5x6) CASE 483AR

PIN ASSIGNMENT

HSG GR V+	1] 2] 3]	*	GND(LSS)	[8 [7 [6	LSG SW SW
V+	4]	l.,	الق	[5]	sw
	*P/	۱D۹	9 V+(F	HSD)	

MARKING DIAGRAM



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Numeric Date Code &K = Lot Code

FDMS1D2N03DSD = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

MOSFET MAXIMUM RATINGS ($T_A = 25^{\circ}C$, Unless otherwise specified)

Symbol	Parameter	Q1	Q2	Unit
V_{DS}	Drain to Source Voltage	30	30	V
V_{GS}	Gate to Source Voltage	+16/–12	+16/–12	V
Ι _D	Drain Current - Continuous (T _C = 25°C) (Note 5)	70	164	А
	- Continuous (T _C = 85°C) (Note 5)	54	126	
	– Continuous (T _A = 25°C)	19 (Note 1a)	37 (Note 1b)	
	– Continuous (T _A = 85°C)	15 (Note 1a)	29 (Note 1b)	
	- Pulsed (T _A = 25°C) (Note 4)	362	1199	
E _{AS}	Single Pulsed Avalanche Energy (Note 3)	121	337	mJ
P _D	Power Dissipation for Single Operation $(T_C = 25^{\circ}C)$ $(T_A = 25^{\circ}C)$	26 2.1 (Note 1a)	42 2.3 (Note 1b)	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	−55 to +150		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Q1	Q2	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	4.8	3.0	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	60 (Note 1a)	55 (Note 1b)	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	130 (Note 1c)	120 (Note 1d)	°C/W

PACKAGE MARKING AND ORDERING INFORMATION

Device	Top Marking	Package	Reel Size	Tape Width	Quantity
FDMS1D2N03DSD	FDMS1D2N03DSD	Power Clip 56 (PGFN8) (Pb-Free / Halogen Free)	13″	12 mm	3,000 Units

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Type	Min	Тур	Max	Unit
OFF CHARACT	ERISTICS						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$	Q1 Q2	30 30	- -	- -	V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I _D = 10 mA, referenced to 25°C	Q1 Q2	- -	15 21	- -	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V	Q1 Q2	- -	- -	1 500	μΑ
I _{GSS}	Gate to Source Leakage Current, Forward	V _{GS} = +16 V/-12 V, V _{DS} = 0 V	Q1 Q2	- -	- -	±100 ±100	nA nA
ON CHARACTE	RISTICS						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 320 \mu A$ $V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	Q1 Q2	0.8 1.0	1.3 1.5	2.5 3.0	V
$\Delta V_{GS(th)}/\Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 1 mA, referenced to 25°C I_D = 10 mA, referenced to 25°C	Q1 Q2	_ _	-3 -3	_ _	mV/°C

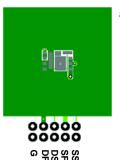
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Unit
N CHARACT	TERISTICS	•					
R _{DS(on)}	Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 19 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 17 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 19 \text{ A},$ $T_J = 125 ^{\circ}\text{C}$	Q1	- - -	2.5 3.0 3.6	3.25 4.0 4.9	mΩ
		$V_{GS} = 10 \text{ V}, I_D = 37 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 34 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 37 \text{ A},$ $T_J = 125^{\circ}\text{C}$	Q2	- - -	0.73 0.93 1.1	0.97 1.25 1.6	
9FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 19 \text{ A}$ $V_{DS} = 5 \text{ V}, I_{D} = 37 \text{ A}$	Q1 Q2	-	95 247	-	S
YNAMIC CH	ARACTERISTICS						
C _{iss}	Input Capacitance	Q1: V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2	_	1410 4860	-	pF
C _{oss}	Output Capacitance	Q2: V _{DS} = 15 V, V _{GS} = 0 V,	Q1 Q2	_	564 1845	-	pF
C _{rss}	Reverse Transfer Capacitance	f = 1 MHZ	Q1 Q2	_	40 123	_	pF
R_g	Gate Resistance		Q1 Q2	_	0.3 0.3	_	Ω
WITCHING C	CHARACTERISTICS						
t _{d(on)}	Turn-On Delay Time	Q1: V _{DD} = 15 V, I _D = 19 A,	Q1 Q2	_	8 13		ns
t _r	Rise Time	$R_{GEN} = 6 \Omega$ Q2: $V_{DD} = 15 V, I_D = 37 A,$	Q1 Q2	_	2 5	<u> </u>	ns
t _{d(off)}	Turn-Off Delay Time	$R_{GEN} = 6 \Omega$	Q1 Q2	_	22 37	_ _	ns
t _f	Fall Time	7	Q1 Q2	_	2 4	<u> </u>	ns
Qg	Total Gate Charge	V _{GS} = 0 V to 10 V Q1: V _{DD} = 15 V, I _D = 19 A Q2: V _{DD} = 15 V, I _D = 37 A	Q1 Q2	- -	23 84	33 117	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ Q1: $V_{DD} = 15 \text{ V}$, $I_{D} = 19 \text{ A}$ Q2: $V_{DD} = 15 \text{ V}$, $I_{D} = 37 \text{ A}$	Q1 Q2	-	11 39	15 54	nC
Q_{gs}	Gate to Source Gate Charge	Q1: V _{DD} = 15 V, I _D = 19 A Q2: V _{DD} = 15 V, I _D = 37 A	Q1 Q2	_	3.1 13	- -	nC
Q_{gd}	Gate to Drain "Miller" Charge	Q1: V _{DD} = 15 V, I _D = 19 A Q2: V _{DD} = 15 V, I _D = 37 A	Q1 Q2	- -	2.5 9	_ _	nC
OURCE-DRA	AIN DIODE CHARACTERISTICS						
V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 19 A (Note 2) V _{GS} = 0 V, I _S = 37 A (Note 2)	Q1 Q2	-	0.8 0.8	1.2 1.2	V
t _{rr}	Reverse Recovery Time	Q1: I _F = 19 A, di/dt = 100 A/μs	Q1 Q2	-	28 43	_	ns
Q _{rr}	Reverse Recovery Charge	Q2: I _F = 37 A, di/dt = 300 A/μs	Q1 Q2		12 63	-	nC

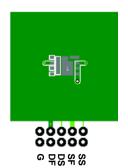
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

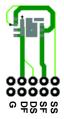
1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 \times 1.5 in. board of FR-4 material. $R_{\theta CA}$ is determined by the user's board design.



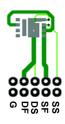
a) 60°C/W when mounted on a 1 in^2 pad of 2 oz copper.



b) 55°C/W when mounted on a 1 in² pad of 2 oz copper.



c) 130°C/W when mounted on a minimum pad of 2 oz copper.



d) 120°C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- Q1: E_{AS} of 121 mJ is based on starting T_J = 25°C; N-ch: L = 3 mH, I_{AS} = 9 A, V_{DD} = 30 V. 100% tested at L = 0.1 mH, I_{AS} = 29 A. Q2: E_{AS} of 337 mJ is based on starting T_J = 25°C; N-ch: L = 3 mH, I_{AS} = 15 A, V_{DD} = 30 V. 100% tested at L = 0.1 mH, I_{AS} = 47 A.
 Pulsed Id please refer to Figure 11 and Figure 24 SOA graphs for more details.
- 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

TYPICAL CHARACTERISTICS (Q1 N-Channel)

(T_J = 25°C unless otherwise noted)

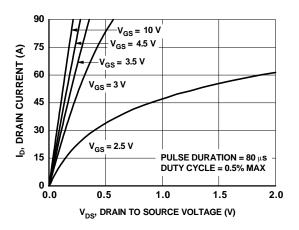


Figure 1. On-Region Characteristics

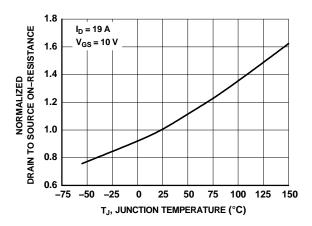


Figure 3. Normalized On-Resistance vs. Junction Temperature

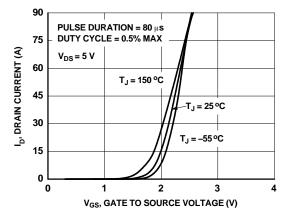


Figure 5. Transfer Characteristics

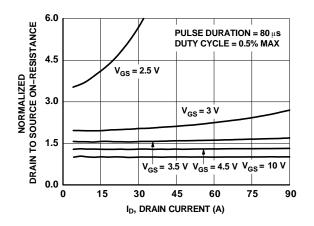


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

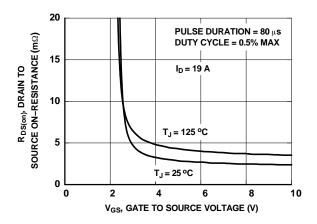


Figure 4. On-Resistance vs. Gate to Source Voltage

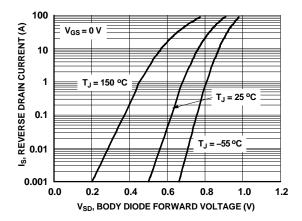


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (Q1 N-Channel)

(T_J = 25°C unless otherwise noted)

10000

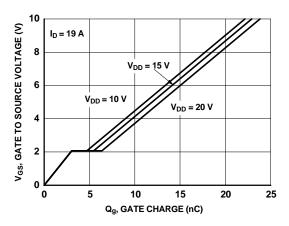


Figure 7. Gate Charge Characteristics

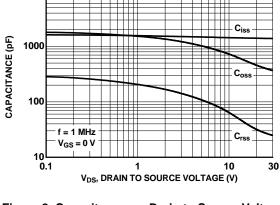


Figure 8. Capacitance vs. Drain to Source Voltage

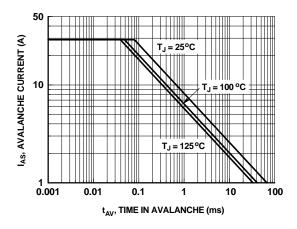


Figure 9. Unclamped Inductive Switching Capability

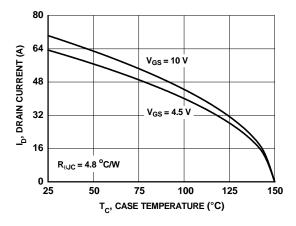


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

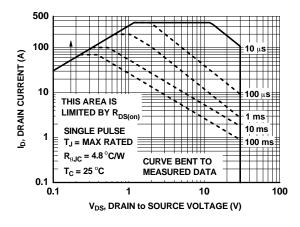


Figure 11. Forward Bias Safe Operating Area

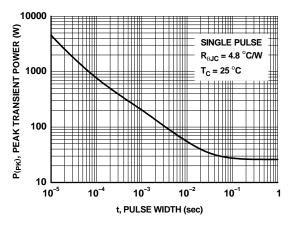


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (Q1 N-Channel)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

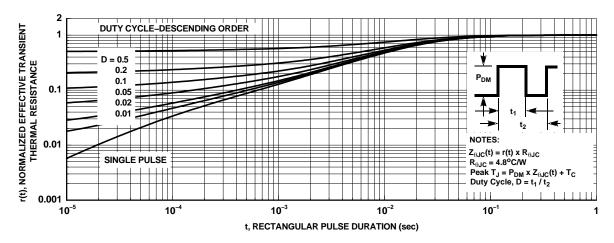


Figure 13. Junction-to-Case Transient Thermal Response Curve

TYPICAL CHARACTERISTICS (Q2 N-Channel)

(T_J = 25°C unless otherwise noted)

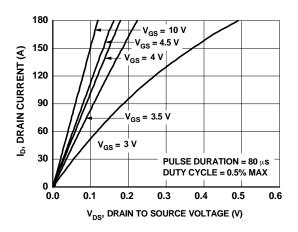


Figure 14. On-Region Characteristics

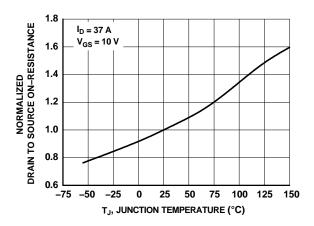


Figure 16. Normalized On-Resistance vs.

Junction Temperature

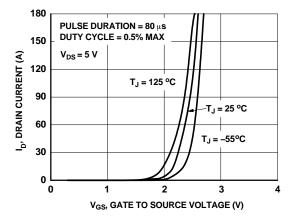


Figure 18. Transfer Characteristics

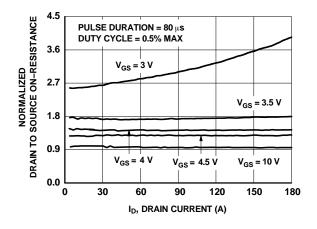


Figure 15. Normalized On-Resistance vs. Drain Current and Gate Voltage

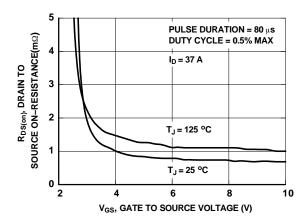


Figure 17. On-Resistance vs. Gate to Source Voltage

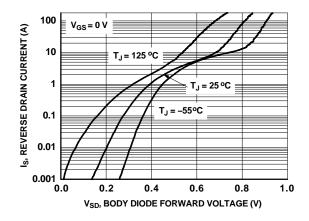


Figure 19. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (Q2 N-Channel)

(T_J = 25°C unless otherwise noted)

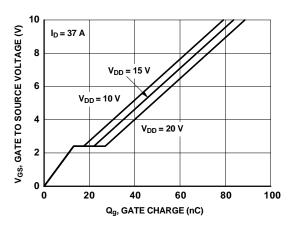


Figure 20. Gate Charge Characteristics

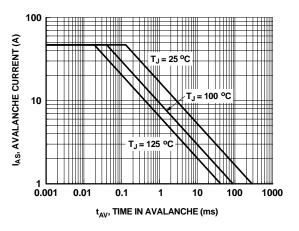


Figure 22. Unclamped Inductive Switching Capability

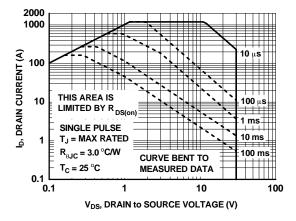


Figure 24. Forward Bias Safe Operating Area

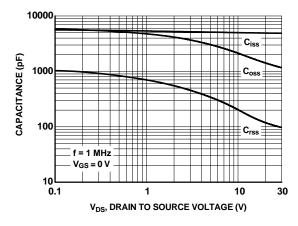


Figure 21. Capacitance vs. Drain to Source Voltage

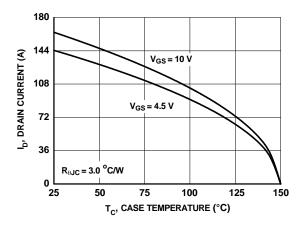


Figure 23. Maximum Continuous Drain Current vs. Case Temperature

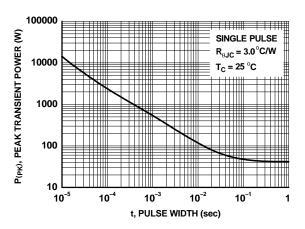


Figure 25. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (Q2 N-Channel)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

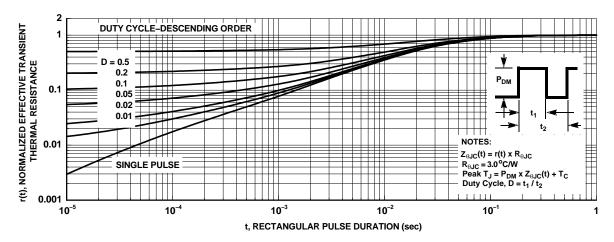


Figure 26. Junction-to-Case Transient Thermal Response Curve

TYPICAL CHARACTERISTICS (continued)

SyncFET Schottky Body Diode Characteristics

ON's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 27 shows the reverse recovery characteristic of the FDMS1D2N03DSD.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

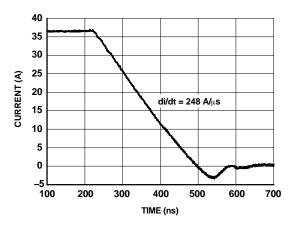


Figure 27. FDMS1D2N03DSD SyncFET Body Diode Reverse Recovery Characteristic

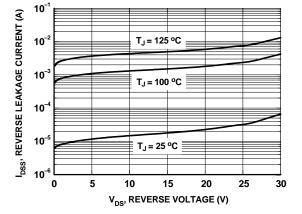
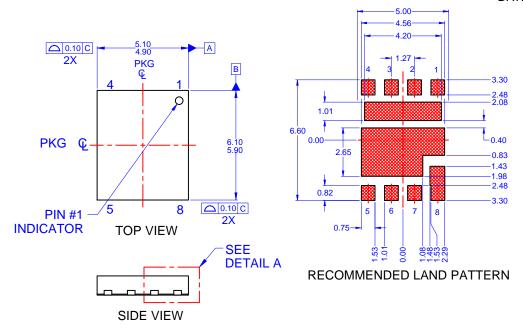


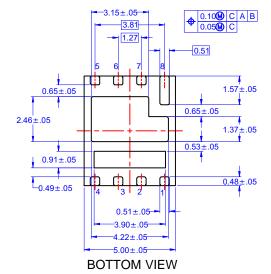
Figure 28. SyncFET Body Diode Reverse Leakage vs.
Drain-Source Voltage

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PQFN8 5X6, 1.27P CASE 483AR ISSUE O

DATE 30 SEP 2016





NOTES: UNLESS OTHERWISE SPECIFIED

- A) DOES NOT FULLY CONFORM TO JEDEC REGISTRATION, MO-229, DATED 11/2001.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.

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